



### 20V N-CHANNEL ENHANCEMENT MODE MOSFET

#### **Features**

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Ultra-Small Surface Mount Package
- Ultra-Low Package Profile, 0.4mm Maximum Package Height
- ESD Protected up to 1.5kV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

### **Mechanical Data**

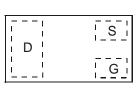
- Case: X2-DFN1006-3
- Case Material: Molded Plastic, "Green" Molding Compound;
  UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe; Solderable per MIL-STD-202, Method 208
- Weight: 0.001 grams (Approximate)

#### X2-DFN1006-3

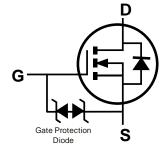




**Bottom View** 



Top View Package Pin Configuration



Equivalent Circuit

### Ordering Information (Note 4)

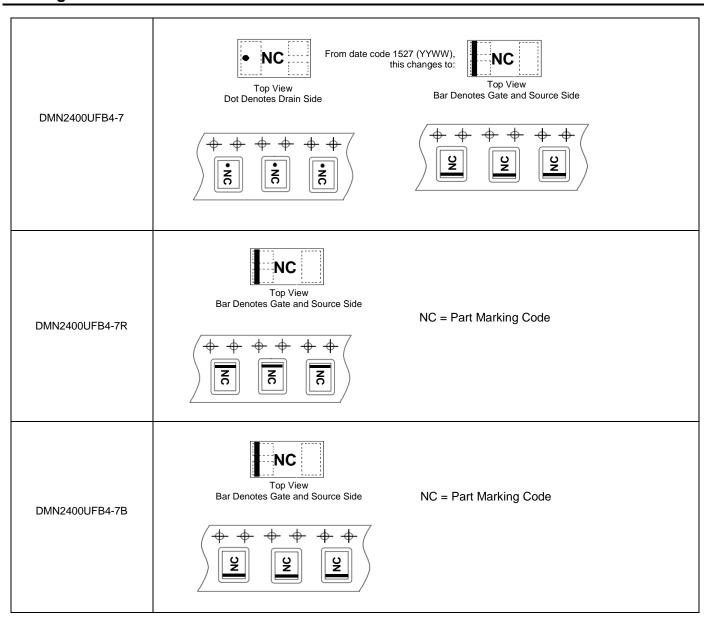
Part Number	Marking	Reel Size (inches)	Tape Width (mm)	Tape Pitch (mm)	Quantity per Reel
DMN2400UFB4-7	NC	7	8	4	3,000
DMN2400UFB4-7R	NC	7	8	4	3,000
DMN2400UFB4-7B	NC	7	8	2	10,000

### Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.



# **Marking Information**





# **Maximum Ratings** ( $@T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Drain-Source Voltage	V <sub>DSS</sub>	20	V		
Gate-Source Voltage	V <sub>GSS</sub>	±12	V		
Continuous Drain Current (Note 5) V <sub>GS</sub> = 4.5V	Steady State	$T_A = +25^{\circ}C$ $T_A = +85^{\circ}C$	I <sub>D</sub>	0.75 0.55	А
Pulsed Drain Current (Notes 5 & 6)		I <sub>DM</sub>	3	Α	

# **Thermal Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	$P_{D}$	0.47	mW
Thermal Resistance, Junction to Ambient	R <sub>0JA</sub>	258	°C/W
Operating and Storage Temperature Range	$T_{J,}T_{STG}$	-55 to +150	°C

Notes:

- 5. Device mounted on FR-4 PCB, with minimum recommended pad layout, single sided.
- 6. Device mounted on minimum recommended pad layout test board, 10µs pulse duty cycle = 1%.

## Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

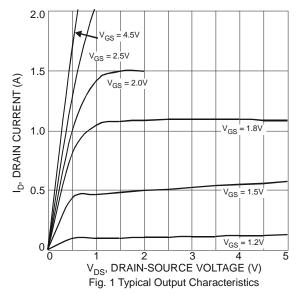
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition			
OFF CHARACTERISTICS (Note 7)									
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	20	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$			
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	_	_	100 50	nA	$V_{DS} = 20V, V_{GS} = 0V$ $V_{DS} = 5V, V_{GS} = 0V$			
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 3V$ , $V_{DS} = 0V$			
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±1.0	μA	$V_{GS} = \pm 4.5V, V_{DS} = 0V$			
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±50	μA	$V_{GS} = \pm 10V, V_{DS} = 0V$			
ON CHARACTERISTICS (Note 7)		•							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	0.5	_	0.9	<b>V</b>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$			
		_	_	0.55	Ω	$V_{GS} = 4.5V, I_D = 600mA$			
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	_	0.75		$V_{GS} = 2.5V, I_D = 500mA$			
	, ,	_	_	0.9		$V_{GS} = 1.8V, I_D = 350mA$			
Forward Transfer Admittance	Y <sub>fs</sub>	_	1.0	_	S	$V_{DS} = 10V, I_D = 400mA$			
Diode Forward Voltage	V <sub>SD</sub>		0.7	1.2	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 150mA			
DYNAMIC CHARACTERISTICS (Note 8)						•			
Input Capacitance	C <sub>iss</sub>	_	36.0	_	рF	101/11/101/			
Output Capacitance	Coss	_	5.7	_	pF	$V_{DS} = 16V, V_{GS} = 0V,$ - f = 1.0MHz			
Reverse Transfer Capacitance	C <sub>rss</sub>	_	4.2	_	pF	1 = 1.0WH12			
Total Gate Charge	Qg	_	0.5	_	nC	$V_{GS} = 4.5V, V_{DS} = 10V,$			
Gate-Source Charge	Q <sub>gs</sub>	_	0.07	_	nC	I <sub>D</sub> = 250mA			
Gate-Drain Charge	Q <sub>gd</sub>	_	0.1	_	nC	7			
Turn-On Delay Time	t <sub>D(ON)</sub>	_	4.11	_	ns				
Turn-On Rise Time	t <sub>R</sub>	_	3.82	_	ns	$V_{DD} = 10V, V_{GS} = 4.5V,$			
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	14.8	_	ns	$R_L = 47\Omega, R_g = 10\Omega,$ $R_D = 200 \text{mA}$			
Turn-Off Fall Time	t <sub>F</sub>	_	9.6	_	ns	ID = ZOUTIA			

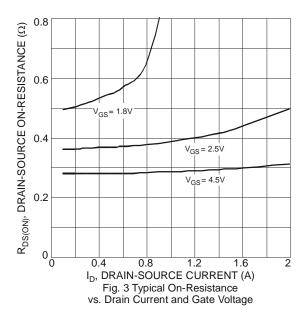
Notes:

- 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to product testing.









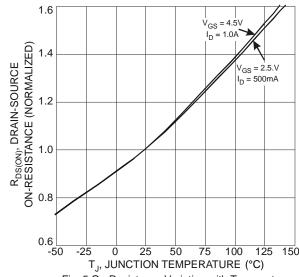
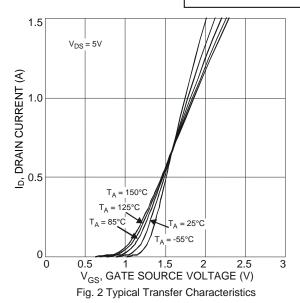


Fig. 5 On-Resistance Variation with Temperature



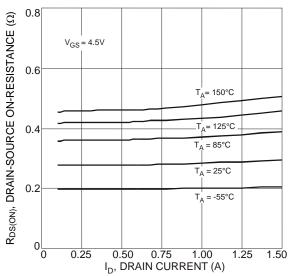


Fig. 4 Typical Drain-Source On-Resistance vs. Drain Current and Temperature

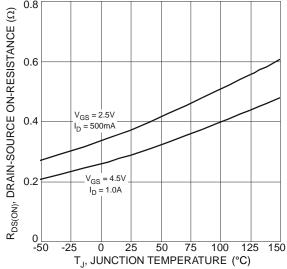


Fig. 6 On-Resistance Variation with Temperature



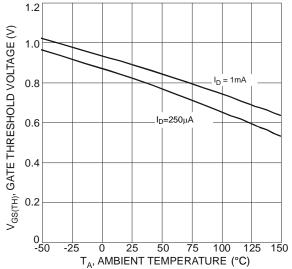
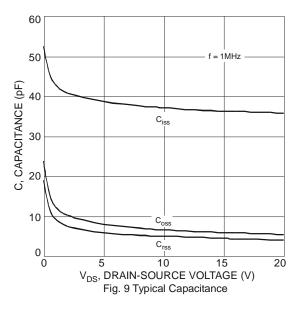
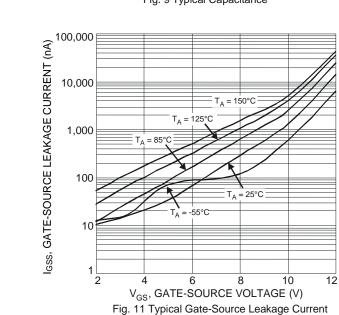
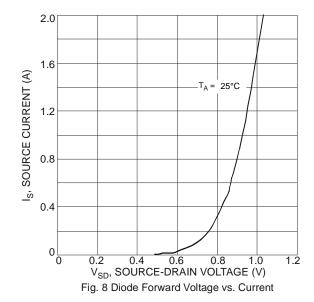


Fig. 7 Gate Threshold Variation vs. Ambient Temperature





vs. Gate-Source Voltage



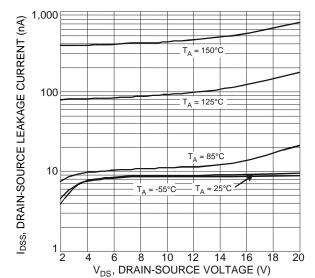


Fig. 10 Typical Drain-Source Leakage Current vs. Drain-Source Voltage

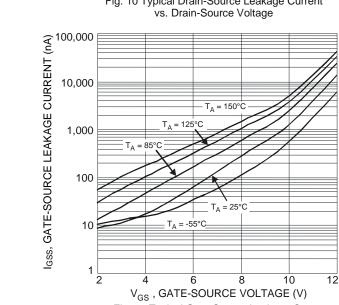


Fig. 12 Typical Gate-Source Leakage Current vs. Gate-Source Voltage



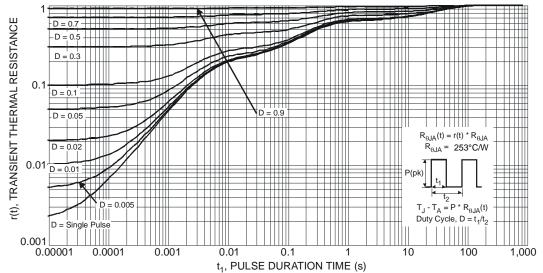


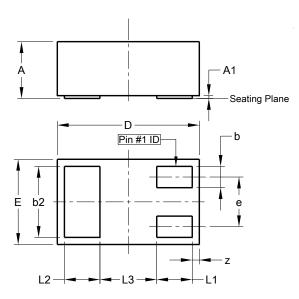
Fig. 13 Transient Thermal Response



## **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### X2-DFN1006-3

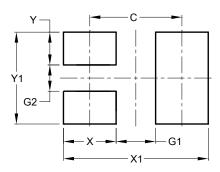


X2-DFN1006-3									
Dim	Dim Min Max Typ								
Α	_	0.40	_						
A1	0.00	0.05	0.03						
b	0.10	0.20	0.15						
b2	0.45	0.55	0.50						
D	0.95	1.05	1.00						
Е	0.55	0.65	0.60						
е	-	-	0.35						
L1	0.20	0.30	0.25						
L2	0.20	0.30	0.25						
L3	-	-	0.40						
Z	0.02	0.08	0.05						
All Di	imens	ions ii	n mm						

## **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### X2-DFN1006-3

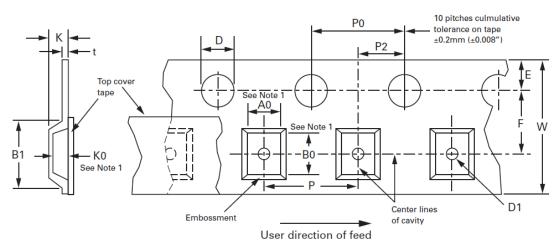


Dimensions	Value (in mm)
С	0.70
G1	0.30
G2	0.20
X	0.40
X1	1.10
Y	0.25
Y1	0.70



# **Tape Information**

## **EMBOSSED CARRIER TAPE SPECIFICATIONS**



8, 12, 16, 24mm EMBOSSED TAPE DIMENSIONS IN mm								
Tape Size      D      E      Po      tmax      Ao Bo Ko								
8mm	1.50 +0.10 -0.0	1.75 ± 0.10	4.0 ± 0.10	0.400	See Note 9	Constant Dimensions		

Tape Size	B1 max	D1 min	F	K max	P2	R min	w	Package Type
8mm	4.5	0.35	$3.5\pm0.05$	2.4	$2.0 \pm 0.05$	25	$8.0 \pm 0.30$	Refer to 8mm Device Tape Orientation Table

P									
Tape Size	2.0 ± 0.05	4.0 ± 0.10	8.0 ± 0.10	12.0 ± 0.10	16.0 ± 0.10				
8mm	DFN1006 (-7B)	DFN1006 (-7) DFN1006 (-7R)	_	_	_				

Note: 9. Ao Bo Ko are determined by component size.



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